MAGNA SYSTEMS LLC

THERMOCOUPLE MONITOR

Model: Thermo Biscuit

16 June 2008 Report No.: SL0800601-MSL-001 (15.249) (Thermo Biscuit)

(This report supersedes NONE)



Modifications made to the product: None

This Test Report is Issued Under the Authority of:								
Cul.	Bi							
Choon Sian Ooi	Leslie Bai							
Test Engineer	Engineering Reviewer							

This test report may be reproduced in full only.

Test result presented in this test report is applicable to the representative sample only.

EMC Test Repor

SIEMIC, INC.
Accessing global markets

 Serial#
 \$L0800601-MSL-001 (15.249) (Thermo Biscuit)

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SIEMIC ACREDITATION DETAILS: NVLAP Lab Code: 200729-0

United States Department of Commerce National Institute of Standards and Technology



Certificate of Accreditation to ISO/IEC 17025:2005

NVLAP LAB CODE: 200729-0

SIEMIC Laboratories

San Jose, CA

is accredited by the National Voluntary Laboratory Accreditation Program for specific services, listed on the Scope of Accreditation, for:

ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS

This laboratory is accredited in accordance with the recognized international Standard ISO/IEC 17025:2005. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communique dated 18 June 2005).

2008-01-01 through 2008-12-31

Effective dates



For the National institute of Standards and Technology

NVLAP-01C (REV. 2006-09-13)

SIEMIC ACREDITATION DETAILS: FCC Registration No. 783147

FEDERAL COMMUNICATIONS COMMISSION

Laboratory Division 7435 Oakland Mills Road Columbia, MD 21046

December 20, 2007

Registration Number: 783147

SIEMIC Laboratories 2206 Ringwood Avenue, San Jose, CA 95131

Attention: Leslie Bai

Re: Measurement facility located at San Jose

3 & 10 meter site

Date of Renewal: December 20, 2007

Dear Sir or Madam:

Your request for renewal of the registration of the subject measurement facility has been received. The information submitted has been placed in your file and the registration has been renewed. The name of your organization will remain on the list of facilities whose measurement data will be accepted in conjunction with applications for Certification under Parts 15 or 18 of the Commission's Rules. Please note that the file must be updated for any changes made to the facility and the registration must be renewed at least every three years.

Measurement facilities that have indicated that they are available to the public to perform measurement services on a fee basis may be found on the FCC website www.fcc.gov under E-Filing, OET Equipment Authorization Electronic Filing, Test Firms.

Sincerely,

Phyllis Parrish Industry Analyst

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OUR HILE: 46405-4842 Submission No: 126429

SL0800601-MSL-001 (15.249) (Thermo Biscuit)

SIEMIC ACREDITATION DETAILS: Industry of Canada Registration No. 4842-1

Industry Industrie Carada Canada

May 23rd, 2008

Siemic Inc. 2205 Ringwood Ave. San Jose CA 95131 USA

Attention: Leslie Bai

Dear Sir Madame:

The Bucest has received your application for the registration / received of > 3/10m OATS. Be advised that the information received was satisfactory to Industry Canada. The following number(s) is now associated to the site(s) for which registration / renewal was sought (4842A-1). Please reference the appropriate site number in the body of test reports containing, measurements performed on the site. In addition, please be informed that the Bureau is now utilizing a new site numbering scheme in order to simplify the electronic filing process. Our goal is to reduce the number of secondary codes associated to one particular company. The following changes have been made to your record.

- Your primary code is: 4842.
- The company number associated to the site(s) located at the above address is: 4842A
- The table below is a summary of the changes made to the unique site registration number(s);

	New Sire Number	Obsolete Site Number	Description of Site	Expiry Date (YYYY-MM-DD)
Γ	4842A-1	4842-1	3m Claimber	2010-05-23

Furthermore, to obtain or renew a unique site number, the applicant shall demonstrate that the site has been accredited to ANSI C63.4-2003 or later. A scope of accreditation indicating the recreditation by a recognized accreditation body to ANSI C63.4-2003 shall be accepted. Please indicate in a letter the previous assigned site number if applicable and the type of site (example: 3 meter OATS or 3 meter chamber). If the test facility is not accredited to ANSI C63.4-2003 or later, the test facility shall submit test data demonstrating full compliance with the ANSI standard. The Bureau will evaluate the filing to determine if recognition shall be granted.

The frequency for re-validation of the test site and the information that is required to be filed or retained by the testing party shall comply with the requirements established by the accrediting organization. However, in all cases, test site re-validation shall occur on an interval not to exceed two years. There is no fee or form associated with an OATS filing. OATS submissions are encouraged to be submitted electronically to the Bureau using the following URL; http://strategis.ie.ge.ea/epie/internet/inceb-Mist.nsf/ew/h_tt00052e.html.

If you have any questions, you may contact the Bureau by e-mail at certification bureau/@ic.gc.c Please reference our file and submission number above for all correspondence

Yours sincerely.

5: Prouds

5. From: Test & Mensuement Specialist Certification and Farencians, Bureau 1701 Cading Ave. Building % Others, Onlario K2H 882

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SIEMIC ACREDITATION DETAILS: Japan VCCI Registration No. 2195



Voluntary Control Council for Interference by Information Technology Equipment 7F NOA Bidg. 2-3-5, Azabudai, Minator-Ku. Tokyo. Japan. 105-0041 Tet+81-3-5575-3138 Fac+81-3-5575-3137 http://www.vocior.jp

February 12, 2004

TO: SIEMIC, INC.

Membership NO: 2195

We confirmed your payment for annual membership fee and admission fee. Thank you very much for your remitting.

Please find enclosed VCCI documents. As admission fee and annual membership fee were confirmed, your company registered as VCCI official member.

From now on, it is possible for your company to submit conformity verification report or/and application for registration of measurement facilities.

Please find necessary forms for your submission from VCCI web-site. www.vcci.or.jp

When you submit conformity verification report, please submit to Ms. Yoko Inagaki / inagaki@voci.or.jp and application for registration of measurement facilities, please submit to Mr. Masaru Denda / denda@voci.or.jp

Their address, phone and fax number are absolutly same as L. Please refer address indicated on top right-hand corner of this page.

If you have any other questions regarding membership, feel free to contact me. Thank you very much.

Best Regards,

Naoko Hori (Ms.) VCCI hori®vcci.or.jp

Enclosure

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SIEMIC ACREDITATION DETAILS: Japan RF Technologies Accreditation No. MRF050927

Certificate

This is to certify that the Quality Management System

SIEMIC, Inc.

2206 Ringwood Avenue San Jose, California 95131 U.S.A.

has been authorized to carry out Japan Specified Radio Equipment test by order and under supervision of RF Technologies Co., Ltd. according to Notification No.88 of Radio Law.

An assessment of the laboratory was conducted according to the "Procedure and Conditions for Appointments of 2,4GHz Band Low power data communications system that Bluetooth and Wireless LAN test with reference to ISO/IEC 17025 by an RF Technologies Co., Ltd. auditor.

Audit Report No. MRF050927

Kazuyuki Sarashina

Auditor

RF Technologies Co., Ltd.

Audit Date September 27th, 2005

President

RF Technologies Co., Ltd.

Issued Date October 5th, 2005

This Certificate is valid until September 26th 2006 or next schedule audit.

No:006 Registered Certification Body RF Technologies Co., Ltd. 472, Nippa-cho, Kohoku-ku, Yokohama, 223-0057, Japan



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SIEMIC ACREDITATION DETAILS: Korea MIC Lab Code: KR0032

시험기관지정서 Certificate

of Designated Testing Laboratory

지정번호(No.) : KR0032

시험기관명 : (주)현대교정인증기술원

(Name of Lab.) (Hundi Calibration & Certification Technologies Co., Ltd)

주 소 : 경기도 이천시 부발음 아미리 산136-1

(Address) (136-1, Ami-ri, Buhal-eup, Ichean-si, Kyunggi-Do, Korea)

2206 Ringwood Avenue San Jose, CA, USA.

시험분야 및 범위 : 유선(Telecommunication Part)

(Area & Category) 무선(Radio Communication Part)

전자과장해(EMI): 미국지사 포함 전자과내성(EMS): 미국지사 포함

전기안전(Safety) 전자파흡수율(SAR)

위 기관을 정보통신기기시험기관지정및관리등에관한규칙에 의해 정보통신기기시험기관으로 지정합니다.

This is to certify that
the above mentioned laboratory is designated
as the testing laboratory in accordance with
the Regulations on Designation of Testing Laboratory
for Information and Communication Equipment.

2005 (Year) 741 (Month) 591 (Date:

전파연구소

Director General of Radio Research Daboratory Ministry of Information and Communication Republic of Korea

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SIEMIC ACREDITATION DETAILS: Korea CAB ID: US0160



UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Gaithersburg, Maryland 20889-

April 17, 2006

Mr. Leslie Bai SIEMIC Laboratories 2206 Ringwood Avenue San Jose, CA 95131

Dear Mr. Bai:

I am pleased to inform you that your laboratory has been recognized by the Ministry of Information and Communication's Radio Research Laboratory (RRL) under the Asia Pacific Economic Cooperation (APEC) Mutual Recognition Arrangement (MRA). Your laboratory is now designated to act as a Conformity Assessment Body (CAB) under Appendix B, Phase I Procedures, of the APEC Tel MRA. The pertinent information about your laboratory's designation is as follows:

CAB Name: SIEMIC Laboratories

Identification No.: US0160

Scope:

Coverage	Standards	Date of Recognition
Electro Magnetic Interference	RRL Notice No. 2005-82: Technical Requirements for Electromagnetic Interference Annex 8(KN-22), RRL Notice No. 2005-131: Conformity Assessment Procedure for Electromagnetic Interference	April 13, 2006
Electro Magnetic Susceptibility	I. RRL Notice No. 2005-130: Technical Requirements for Electromagnetic Susceptibility Annex 1-7(KN-61000-4-2, 4-3, -4-4, -4-5, -4-6, -4-8, -4-11). RRL Notice No. 2005-132: Conformity Assessment Procedure for Electromagnetic Susceptibility Conformagnetic Susceptibility Conformagne	April 13, 2006

You may submit test data to RRL to verify that the equipment to be imported into Korea satisfies the applicable requirements. The designation of your organization will remain in force as long as its accreditation for the designated scope remains valid and comply with the designation requirements.

The names of all recognized CABs will be posted on the NIST website at http://ts.nist.gov/mra. If you have any questions please contact Mr. Jogindar (Joe) Dhillon at (301) 975-5521. We appreciate your continued interest in our international conformity assessment activities.

Sincerely,

David F. Alderman

Group Leader, Standards Coordination and Conformity Group

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cc. Jogindar Dhillon

NIST

SIEMIC ACREDITATION DETAILS: Taiwan BSMI Accreditation No. SL2-IN-E-1130R



UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Gathersburg, Maryland 20898-

May 3, 2006

Mr. Leslie Bai SIEMIC Laboratories 2206 Ringwood Avenue San Jose, CA 95131

Dear Mr. Bai:

I am pleased to inform you that your laboratory has been recognized by the Chinese Taipei's Bureau of Standards, Metrology, and Inspection (BSMI) under the Asia Pacific Economic Cooperation (APEC) Mutual Recognition Arrangement (MRA). Your laboratory is now designated to act as a Conformity Assessment Body (CAB) under Appendix B, Phase I Procedures, of the APEC Tel MRA. You may submit test data to BSMI to verify that the equipment to be imported into Chinese Taipei satisfies the applicable requirements. The designation of your organization will remain in force as long as its accreditation for the designated scope remains valid and comply with the designation requirements. The pertinent designation information is as follows:

BSMI number: SL2-IN-E-1130R (Must be applied to the test reports)

- U.S Identification No: US0160
- Scope of Designation: CNS 13438
- Authorized signatory: Mr. Leslie Bai

The names of all recognized CABs will be posted on the NIST website at http://ts.nist.gov/mra. If you have any questions, please contact Mr. Dhillon at 301-975-5521. We appreciate your continued interest in our international conformity assessment activities.

Sincerely,

David F. Alderman

Group Leader, Standards Coordination and Conformity Group

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ec: Jogindar Dhillon



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SIEMIC ACREDITATION DETAILS: Taiwan NCC CAB ID: US0160



UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Sethersburg, Maryland 20899-

August 8, 2006

Mr. Leslie Bai SIEMIC Laboratories 2206 Ringwood Avenue San Jose, CA 95131

Dear Mr. Bai:

I am pleased to inform you that SIEMIC Laboratories has been recognized by the Chinese Taipei's National Communications Commission (NCC) under the Asia Pacific Economic Cooperation for Telecommunications and Information, Mutual Recognition Arrangement (APEC Tel MRA). Your laboratory is now designated to act as a Conformity Assessment Body (CAB) under Appendix B, Phase I Procedures, of the APEC Tel MRA.

You may submit test data to NCC to verify that the equipment to be imported into Chinese Taipei satisfies their applicable requirements using the following guidelines:

- Your laboratory's assigned 6-digit U.S. identification number is US0160. You should reference this number in your correspondence.
- The scope of designation is limited to LP0002. Your designation will remain in force as long as your accreditation remains valid for the scope of designation.

If you have any questions please contact Mr. Jogindar Dhillon via email at dhillon@nist.gov or via fax at 301-975-5414. The names of all recognized laboratories will be posted on the NIST website at http://ts.nist.gov/mra. We appreciate your continued interest in our international conformity assessment activities.

Sincerely,

David F. Alderman

Group Leader, Standards Coordination and Conformity Group

cc: Jogindar Dhillon

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SIEMIC ACREDITATION DETAILS: Mexico NOM Recognition



Laboratorio Valentín V. Rivero

México D.F. a 16 de octubre de 2006.

LESLIE BAI DIRECTOR OF CERTIFICATION SIEMIC LABORATORIES, INC. ACCESSING GLOBAL MARKETS PRESENTE

En contestación a su escrito de fecha 5 de septiembre del año en curso, le comento que estamos muy interesados en su intención de firmar un Acuerdo de Reconocimiento Mutuo, para lo cual adjunto a este escrito encontrara el Acuerdo en idioma ingles y español prefenado de los cuales le pido sea revisado y en su caso corregido, para que si esta de acuerdo poder firmarlo para mandario con las autoridades Mexicanas para su visto bueno y así poder ejercer dicho acuerdo.

Aprovecho este escrito para mencionarle que nuestro intermediario gestor será la empresa isatel de México. S. A. de C. V., empresa que ha colaborado durante mucho tiempo con nosotros en lo relacionado a la evaluación de la conformidad y que cuenta con amplia experiencia en la gestoria de la certificación de cumplimiento con Normas Oficiales Mexicanas de producto en México.

Me despido de ustad enviêndole un cordial saludo y esperando sus comentarios al Acuerdo que nos soupa.

Atentamente:

Ing. Fausting-Borlez González Gerorite-Montico del Laboratorio de

ADVIEN

Cultanin P1 Haderone Condesa Ce 100 Mayon, D.F. Ser. 5264-6938 con 12 lines Fax 5364-0476

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SIEMIC ACREDITATION DETAILS: Hong Kong OFTA Recognition No. D23/16V



Your Ref 來商檔號: Our Ref 本局檔號: D23/16 V Telephone 電話: (852) 2961 6320 Fax No 副文傳真: (852) 2838 5004

E-mail 電影地址:

20 July 2005

Mr. Leslie Bai Director of Certification, SIEMIC Laboratories 2206 Ringwood Avenue San Jose, California 95131 USA

Dear Mr. Bai,

Application of Recognised Testing Agency (RTA)

Referring your submission of 28 June 2005 in relation to the application of RTA, I am pleased to inform you that OFTA has appointed SIEMIC Laboratories (SIEMIC) as a Recognised Testing Agency (RTA):

Please note that, under the Hong Kong Telecommunications Equipment Evaluation and Certification (HKTEC) Scheme, SIEMIC is authorized to conduct evaluation tests on telecommunications equipment against the following HKTA specifications:

> Scope of recognition (HKTA Specifications): 1001, 1002, 1004, 1006, 1007, 1008

1010, 1015, 1016

1022, 1026, 1027, 1029

1030, 1031, 1032, 1033, 1034, 1035, 1039

1041, 1042, 1043, 1045, 1047, 1048

2001

You are requested to refer to and comply with the code of practice and guidelines for RTA as given in the Information Note OFTA 1411 "Recognised Testing Agency (RTA) for Conducting Evaluation Test of Telecommunications Equipment", which can be downloaded from OFTA's homepage at http://www.ofta.gov.hk/tec/information-notes.html.

If you have any queries, please do not hesitate to contact me.

Yours sincerely,

(K K Sin)

for Director-General of Telecommunications

Office of the Telecommunications Authority 29/F Wu Chung House 213 Queen's Road East Wan Chai Hong Kong http://www.ofta.gov.hk

電訊管理局

香港灣仔皇后大道東 213 號胡忠大廈 29 字樓

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1 Executive Summary & EUT information

The purpose of this test programme was to demonstrate compliance of the Magna Systems LLC, model: Thermo Biscuit against the current Stipulated Standards. The Thermocouple Monitor have demonstrated compliance with the FCC 15.249 2007 & IC RSS210 Issue 7: 2007.

EUT Information

EUT Description

The Magna System ThermoBiscuit is a full featured eight (8) channel wireless thermocouple monitor designed for the food service industry. When used with DATALink software from Magna, the ThermoBiscuit wirelessly reports and records temperature data from inside ovens, cooling tunnels and freezer lines. Temperature data form inside ovens, cooling tunnels and freezer lines. Temperature data is available immediately and may be monitored during process steps for real-time analysis and action. The system automatically alerts users to open thermocouples and week battery conditions. Acquires data is easily manipulated using popular Windows program such as Excel PowerPoint and word.

Model No : Thermo Biscuit

Serial No : N/A
Input Power : 3Vdc

Classification Per Stipulated

DXT

Test Standard



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	2 <u>TECHNICAL DETAILS</u>
Purpose	Compliance testing of Thermocouple Monitor with stipulated standard
Applicant / Client	Magna Systems LLC
Manufacturer	Magna Systems LLC 450C First Street Los Altos, CA 94022
Laboratory performing the tests	SIEMIC Laboratories
Test report reference number	SL0800601-MSL-001 (15.249) (Thermo Biscuit)
Date EUT received	25 February 2008
Standard applied	47 CFR §15.249: 2007 & RSS 210 Issue 7: 2007
Dates of test (from - to)	21 April 2008 – 25 April 2008
No of Units:	2
Equipment Category:	DXT
Trade Name:	Magna Systems LLC
Model:	Thermo Biscuit
RF Operating Frequency (ies)	915MHz
Number of Channels :	1
Modulation : FCC ID :	FSK VCD MACNA499
IC ID :	VGD-MAGNA688 7231A-MAGNA688
ICID:	7231A-IVIAGINA088



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3 MODIFICATION

NONE

4 TEST SUMMARY

The product was tested in accordance with the following specifications. All testing has been performed according to below product classification:

DXT

Test Results Summary

Test Star	ndard	Description	Pass / Fail	
47 CFR Part 15.249: 2007	RSS 210 Issue 7: 2007	Description	Pass/Fall	
15.203		Antenna Requirement	Pass	
15.209; 15.249	RSS210(A2.9)	Radiated Spurious Emissions	Pass	
	RSS Gen (4.8)	Receiver Spurious Emissions	Pass	

ANSI C63.4: 2003/ RSS-Gen Issue 2: 2007

PS: All measurement uncertainties are not taken into consideration for all presented test result.

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5 MEASUREMENTS, EXAMINATION AND DERIVED RESULTS

5.1 Antenna Requirement

Requirement(s): 47 CFR §15.203

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

Antenna requirement must meet at least one of the following:

- a) Antenna must be permanently attached to the device.
- b) Antenna must use a unique type of connector to attach to the device.
- c) Device must be professionally installed. Installer shall be responsible for ensuring that the correct antenna is employed with the device.
- 1) The EUT antenna is attached permanently to the device which meets the requirement.

5.2 Radiated Spurious Emission < 1GHz

- All possible modes of operation were investigated. Only the 6 worst case emissions measured, using the correct CISPR detectors, are reported. All other emissions were relatively insignificant.
- 2. A "-ve" margin indicates a PASS as it refers to the margin present below the limit line at the particular frequency.

3. Radiated Emissions Measurement Uncertainty

All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, in the

range 30MHz - 1GHz & 1GHz above (3m & 10m) is +/-6dB.

Environmental Conditions

Temperature
23°C - 25°C
Relative Humidity
50%

Atmospheric Pressure 1019mbar

Test Date: April 21 to April 25, 2008

Tested By: Choon Sian Ooi

Standard Requirement: 47 CFR §15.249

Procedures: Radiated emissions were measured according to ANSI C63.4. The EUT was set to transmit at the highest output

power. The EUT was set to transmit at mid channel. Note that setting the channel other than mid, the spurious

emissions are the same.

The limit is converted from microvolts/meter to decibel microvolts/meter.

Sample Calculation: Corrected Amplitude = Raw Amplitude (dBµV/m) + ACF(dB) + Cable Loss(dB)

Test Result:

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Fundamental

Configuration-1 without Metal Cover

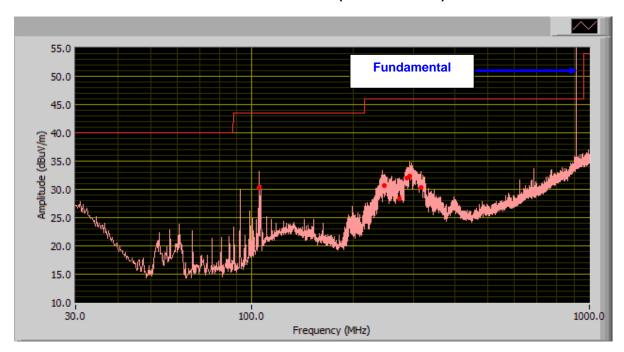
Frequency (MHz)	Polarity	Factor(dB)	Raw reading(dBuV/m)	Corrected Reading (dBuv/m)	Limit (dB)	margin (dB)
915	V	3.08	85.18	88.26	94.00	-5.74
915	Н	3.08	81.87	84.95	94.00	-9.05

Configuration-1 with Metal Cover

Frequency (MHz)	Polarity	Factor(dB)	Raw reading(dBuV/m)	Corrected Reading (dBuv/m)	Limit (dB)	margin (dB)
915	V	3.08	83.63	86.71	94.00	-7.29
915	Н	3.08	80.45	83.53	94.00	-10.47

Configuration-1 with Metal Cover

Radiated Emission Plot (Transmit mode)

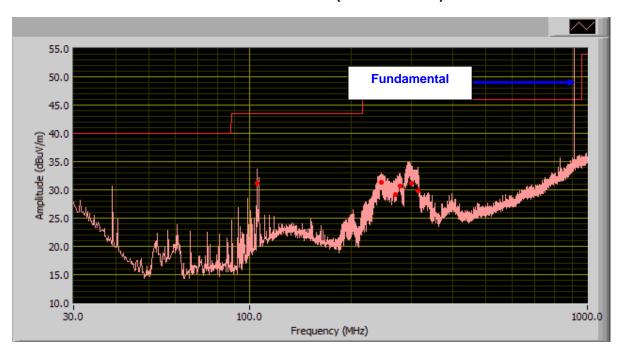


Test Data

Frequency (MHz)	Quasi-Peak (dBµV/m)	Antenna height (cm)	Polarity	Turntable position (deg)	Limit (dBµV/m)	Margin (dB)
104.89	30.34	112.00	V	332.00	43.50	-13.16
293.75	32.28	107.00	Н	144.00	46.00	-13.72
287.86	31.95	101.00	Н	144.00	46.00	-14.05
316.26	30.40	105.00	Н	137.00	46.00	-15.60
246.98	30.66	111.00	Н	135.00	46.00	-15.34
273.01	28.37	101.00	Н	242.00	46.00	-17.63

Configuration-1 without Metal Cover

Radiated Emission Plot (Transmit mode)



Test Data

Frequency (MHz)	Quasi-Peak (dBµV/m)	Antenna height (cm)	Polarity	Turntable position (deg)	Limit (dBµV/m)	Margin (dB)
105.01	31.16	100.00	V	340.00	43.50	-12.34
301.66	31.24	105.00	Н	151.00	46.00	-14.76
315.28	29.79	116.00	Н	151.00	46.00	-16.21
245.45	31.32	113.00	Н	140.00	46.00	-14.68
279.32	30.66	105.00	Н	137.00	46.00	-15.34
269.83	29.08	104.00	Н	139.00	46.00	-16.92

Radiated Emission (Receive mode)

No emission found

5.12 Radiated Spurious Emissions > 1GHz

- 1. All possible modes of operation were investigated. Only the 6 worst case emissions measured, using the correct CISPR detectors, are reported. All other emissions were relatively insignificant.
- 2. A "-ve" margin indicates a PASS as it refers to the margin present below the limit line at the particular frequency.
- 3. All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, in the range 30MHz 1GHz & 1GHz above (3m & 10m) is +/-6dB.

4. Environmental Conditions Temperature 23°C - 25°C

Relative Humidity 50% Atmospheric Pressure 1019mbar

Test Date: April 21 to April 25, 2008 Tested By: Choon Sian Ooi

Standard Requirement: 47 CFR §15.249

Procedures: Equipment was setup in a semi-anechoic chamber. For measurements above 1 GHz an average measurement was taken with a 10Hz video bandwidth. The EUT was tested at low, mid and high with the highest output power. Investigated up to 10th harmonics of the operating frequency.

Sample Calculation:

EUT Field Strength = Raw Amplitude(dBµV/m) – Amplifier Gain(dB) + Antenna Factor(dB) + Cable Loss(dB) + Filter Attenuation(dB, if used)

NOTE: All the test was done when the both radio was turn on to simulate the worst case.

Test Result:

Configuration-1 with Metal Cover

@ 915MHz @ 3 Meter

Frequency	Reading	Direction	Height	Polar	Antenna Loss	Cable loss	Amplifier	Corrected Reading	Limit	Margin	
1.83	43.50	180.00	155.00	٧	26.40	2.16	31.98	40.08	74.00	-33.92	Peak
1.83	43.06	180.00	155.00	h	26.40	2.16	31.98	39.64	74.00	-34.36	Peak
1.83	32.25	180.00	155.00	٧	26.40	2.16	31.98	28.83	54.00	-25.17	Ave
1.83	31.53	180.00	155.00	h	26.40	2.16	31.98	28.11	54.00	-25.89	Ave
2.74	43.23	180.00	155.00	٧	29.80	2.72	32.08	43.67	74.00	-30.33	Peak
2.74	43.34	180.00	155.00	h	29.80	2.72	32.08	43.78	74.00	-30.22	Peak
2.74	32.12	180.00	155.00	٧	29.80	2.72	32.08	32.56	54.00	-21.44	Ave
2.74	31.01	180.00	155.00	h	29.80	2.72	32.08	31.45	54.00	-22.55	Ave
3.66	43.65	180.00	155.00	٧	32.50	3.44	32.37	47.22	74.00	-26.79	Peak
3.66	42.23	180.00	155.00	h	32.50	3.44	32.37	45.80	74.00	-28.21	Peak
3.66	35.18	180.00	155.00	٧	32.50	3.44	32.37	38.75	54.00	-15.26	Ave
3.66	32.77	180.00	155.00	h	32.50	3.44	32.37	36.34	54.00	-17.67	Ave

Emission was scanned up to 10GHz.

Configuration-1 without Metal Cover

@ 915MHz @ 3 Meter

Frequency	Reading	Direction	Height	Polar	Antenna Loss	Cable loss	Amplifier	Corrected Reading	Limit	Margin	
1.83	44.19	180.00	155.00	٧	26.40	2.16	31.98	40.77	74.00	-33.23	Peak
1.83	43.01	180.00	155.00	h	26.40	2.16	31.98	39.59	74.00	-34.41	Peak
1.83	33.21	180.00	155.00	٧	26.40	2.16	31.98	29.79	54.00	-24.21	Ave
1.83	32.92	180.00	155.00	h	26.40	2.16	31.98	29.50	54.00	-24.50	Ave
2.74	44.67	180.00	155.00	٧	29.80	2.72	32.08	45.11	74.00	-28.89	Peak
2.74	44.45	180.00	155.00	h	29.80	2.72	32.08	44.89	74.00	-29.11	Peak
2.74	33.34	180.00	155.00	V	29.80	2.72	32.08	33.78	54.00	-20.22	Ave
2.74	32.12	180.00	155.00	h	29.80	2.72	32.08	32.56	54.00	-21.44	Ave
3.66	44.56	180.00	155.00	V	32.50	3.44	32.37	48.13	74.00	-25.88	Peak
3.66	43.31	180.00	155.00	h	32.50	3.44	32.37	46.88	74.00	-27.13	Peak
3.66	35.21	180.00	155.00	V	32.50	3.44	32.37	38.78	54.00	-15.23	Ave
3.66	34.12	180.00	155.00	h	32.50	3.44	32.37	37.69	54.00	-16.32	Ave

Emission was scanned up to 10GHz.

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Annex A. TEST INSTRUMENT & METHOD

Annex A.i. TEST INSTRUMENTATION & GENERAL PROCEDURES

Instrument	Model	Serial #	Calibration Due
Radiated Emissions			
R&S EMI Test Receiver	ESIB 40	100179	4/25/2009
Pre-Amplifier (100M-1.3GHz)	8447F	1937A01160	4/24/2009
DoubleRidged Waveguide Horn Antenna (1-18GHz)	3115	10SL0059	10/4/2008
Sunol Sciences, Inc. antenna (30MHz~2GHz)	JB1	A030702	10/04/2008
Pre-Amplifier (1-26.5GHz)	8449B	3008A00715	4/24/2009

Annex A.ii. CONDUCTED EMISSIONS TEST DESCRIPTION

Test Set-up

- 1. The EUT and supporting equipment were set up in accordance with the requirements of the standard on top of a 1.5m x 1m x 0.8m high, non-metallic table, as shown in <u>Annex B</u>.
- 2. The power supply for the EUT was fed through a $50\Omega/50\mu H$ EUT LISN, connected to filtered mains.
- 3. The RF OUT of the EUT LISN was connected to the EMI test receiver via a low-loss coaxial cable.
- 4. All other supporting equipments were powered separately from another main supply.

Test Method

- 1. The EUT was switched on and allowed to warm up to its normal operating condition.
- 2. A scan was made on the NEUTRAL line (for AC mains) or Earth line (for DC power) over the required frequency range using an EMI test receiver.
- 3. High peaks, relative to the limit line, were then selected.
- 4. The EMI test receiver was then tuned to the selected frequencies and the necessary measurements made with a receiver bandwidth setting of 10 KHz. For FCC tests, only Quasi-peak measurements were made; while for CISPR/EN tests, both Quasi-peak and Average measurements were made.
- 5. Steps 2 to 4 were then repeated for the LIVE line (for AC mains) or DC line (for DC power).

Sample Calculation Example

At 20 MHz limit = 250 μ V = 47.96 dB μ V

Transducer factor of LISN, pulse limiter & cable loss at 20 MHz = 11.20 dB

Q-P reading obtained directly from EMI Receiver = $40.00 \text{ dB}\mu\text{V}$ (Calibrated for system losses)

Therefore, Q-P margin = 47.96 - 40.00 = 7.96 i.e. **7.96 dB below limit**

Annex A. iii RADIATED EMISSIONS TEST DESCRIPTION

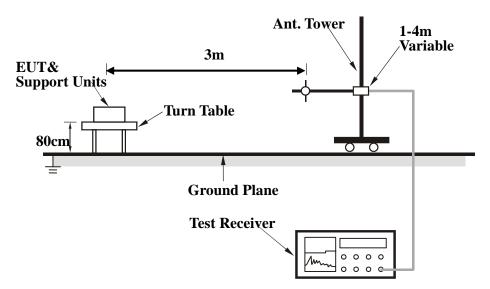
EUT Characterisation

EUT characterisation, over the frequency range from 30MHz to 10th Harmonic , was done in order to minimise radiated emissions testing time while still maintaining high confidence in the test results.

The EUT was placed in the chamber, at a height of about 0.8m on a turntable. Its radiated emissions frequency profile was observed, using a spectrum analyzer /receiver with the appropriate broadband antenna placed 3m away from the EUT. Radiated emissions from the EUT were maximised by rotating the turntable manually, changing the antenna polarisation and manipulating the EUT cables while observing the frequency profile on the spectrum analyzer / receiver. Frequency points at which maximum emissions occurred, clock frequencies and operating frequencies were then noted for the formal radiated emissions test at the Open Area Test Site (OATS).

Test Set-up

- 1. The EUT and supporting equipment were set up in accordance with the requirements of the standard on top of a 1.5m X 1.0m X 0.8m high, non-metallic table.
- 2. The filtered power supply for the EUT and supporting equipment were tapped from the appropriate power sockets located on the turntable.
- 3. The relevant broadband antenna was set at the required test distance away from the EUT and supporting equipment boundary.



Test Method

The following procedure was performed to determine the maximum emission axis of EUT:

- 1. With the receiving antenna is H polarization, rotate the EUT in turns with three orthogonal axes to determine the axis of maximum emission.
- 2. With the receiving antenna is V polarization, rotate the EUT in turns with three orthogonal axes to determine the axis of maximum emission.
- 3. Compare the results derived from above two steps. So, the axis of maximum emission from EUT was determined and the configuration was used to perform the final measurement.

Final Radiated Emission Measurement

- 1. Setup the configuration according to figure 1. Turn on EUT and make sure that it is in normal function.
- 2. For emission frequencies measured below 1 GHz, a pre-scan is performed in a shielded chamber to determine the accurate frequencies of higher emissions will be checked on a open test site. As the same purpose, for emission frequencies measured above 1 GHz, a pre-scan also be performed with a 1 meter measuring distance before final test.
- 3. For emission frequencies measured below and above 1 GHz, set the spectrum analyzer on a 100 kHz and 1 MHz resolution bandwidth respectively for each frequency measured in step 2.
- 4. The search antenna is to be raised and lowered over a range from 1 to 4 meters in horizontally polarized orientation. Position the highness when the highest value is indicated on spectrum analyzer, then change the orientation of EUT on test table over a range from 0 ° to 360 ° with a speed as slow as possible, and keep the azimuth that highest emission is indicated on the spectrum analyzer. Vary the antenna position again and record the highest value as a final reading.
- 5. Repeat step 4 until all frequencies need to be measured were complete.
- 6. Repeat step 5 with search antenna in vertical polarized orientations.

During the radiated emission test, the Spectrum Analyzer was set with the following configurations:

	Frequency Band (MHz)	Function	Resolution bandwidth	Video Bandwidth
	30 to 1000	Peak	100 kHz	100 kHz
Γ	Above 1000	Peak	1 MHz	1 MHz
		Average	1 MHz	10 Hz

Sample Calculation Example

The field strength is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain (if any) from the measured reading. For the limit is employed average value, therefore the peak value can be transferred to average value by subtracting the duty factor. The basic equation with a sample calculation is as follows:

Peak = Reading + Corrected Factor

where

Corr. Factor = Antenna Factor + Cable Factor - Amplifier Gain (if any)

And the average value is

Average = Peak Value + Duty Factor or Set RBW = 1MHz, VBW = 10Hz.

Note:

If the measured frequencies are fall in the restricted frequency band, the limit employed must be quasi peak value when frequencies are below or equal to 1 GHz. And the measuring instrument is set to quasi peak detector function.

Annex B EUT AND TEST SETUP PHOTOGRAPHS

Please see the attachment

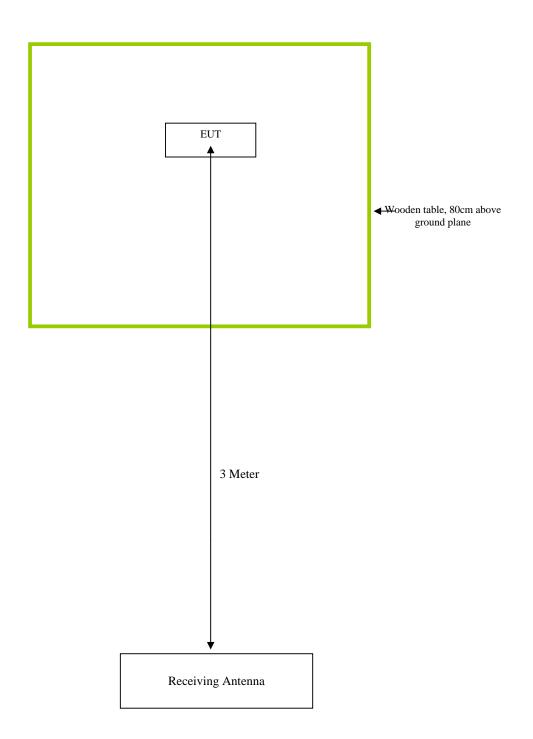
Annex C. TEST SETUP AND SUPPORTING EQUIPMENT

EUT TEST CONDITIONS

Annex C. i. SUPPORTING EQUIPMENT DESCRIPTION

No Supporting Equipments

Block Configuration Diagram for Radiated Emission



Block Configuration Diagram for Conducted Emission

N/A

Annex C.ii. EUT OPERATING CONDITIONS

The following is the description of how the EUT is exercised during testing.

Test	Description Of Operation		
Emissions Testing	The EUT was power up		
Others Testing	The EUT was power up		

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Annex D USER MANUAL, BLOCK & CIRCUIT DIAGRAM

Please see attachment